

**DOCKET NO.: 218478 US** 

## 0/030123

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Yasuji HIRAMATSU, et al.

SERIAL NO.: NEW U.S. PCT APPLICATION

FILED: HEREWITH

INTERNATIONAL APPLICATION NO.: PCT/JP01/04438

INTERNATIONAL FILING DATE: May 28, 2001

FOR: SEMICONDUCTOR-PRODUCING/EXAMINING DEVICE

## **REQUEST FOR PRIORITY UNDER 35 U.S.C. 119** AND THE INTERNATIONAL CONVENTION

**Assistant Commissioner for Patents** Washington, D.C. 20231

Sir:

In the matter of the above-identified application for patent, notice is hereby given that the applicant claims as priority:

**COUNTRY** 

**APPLICATION NO** 

DAY/MONTH/YEAR

Japan

2000-156876

26 May 2000

Certified copies of the corresponding Convention application(s) were submitted to the International Bureau in PCT Application No. PCT/JP01/04438. Receipt of the certified copy(s) by the International Bureau in a timely manner under PCT Rule 17.1(a) has been acknowledged as evidenced by the attached PCT/IB/304.

> Respectfully submitted, OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

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